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					Complete if Known		
				*	Application Number	New Application	
	INFORMA				Filing Date	Herewith	
	STATEME	NI BY API	PLICAI	NI	First Named Inventor	Fariba HATAMI et al	
					Group Art Unit	10584882 - GAU: 2815	
					Examiner Name	Jay C. Kim	
					Confirmation No.		
	Sheet	1	of	4	Attorney Docket Number	3367-103	

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Examiner	Cite No.1	U.S. Patent Document  Number Kind Co				Date of Publication of Cited Document MM-DD-YYYY	
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<sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code. <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.

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				Con	Complete if Known		
				Application Number	New Application 4882		
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STATEME	NI BY API	PLICA	N I	First Named Inventor	Fariba HATAMI et al		
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Sheet	2	of	4	Attorney Docket Number	3367-103		

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Examiner Signature					Date Conside	red	03/11/2009	

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				Confirmation No.		
Sheet	3	of	4	Attorney Docket Number	3367-103	

		NON PATENT LITERATURE DOCUMENTS	
Examiner Initials*	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, of	T²
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				Application Number	Ne <b>1</b> Ap/15 B418182	
INFORMA'				Filing Date	Herewith	
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